Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/758,836	MURAKAMI ET AL.
Examiner	Art Unit

Nam V. Nguyen

2612

SEARCHED					
Class	Subclass	Date	Examiner		
340	5.82	10/17/2007	NN		
340	5.8-5.84	10/17/2007	NN .		
340	5.52-5.53	10/17/2007	NN		
382	124	10/17/2007	NN		
382	115	10/17/2007	NN		
235	380	10/17/2007	NN		
235	492	10/17/2007	NN		
235	379	10/17/2007	NN		
235	381	10/17/2007	NN		
455	411	10/17/2007	NN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Seach East: USPAT; US-PUB; EPO; JPO; and Derwent. (updated search).	10/17/2007	NN
Search Terms: biometric sensors; ic/credit card; reflected signal/wave with biometric sensors with smart card; portable dev.	10/17/2007	NN